Sim ple model for the linear temperature dependence of the electrical resistivity of layered cuprates

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A bstract

The therm all uctuations of the electric eld between the CuO $_2$ planes of layered cuprates are considered as an origin of the electrical resistivity. The model evaluation employs a set of separate plane capacitors each having area equal to the squared in-plane lattice constant a_0^2 : It is shown that the scattering of charge carriers by the uctuation of electric charge in the conducting CuO $_2$ planes gives rise to the in-plane electrical resistivity $_{ab}$: Such a mechanism can be viewed as an analog of the R ayleigh's blue-sky law | the charge carriers are scattered by therm all uctuations of electron density.

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I. IN TRODUCTION

The linear tem perature dependence of the electrical resistivity $_{ab}$ / T [1{3] is one of the most important properties of the normal phase kinetics of high-T_c layered cuprates [4,5]. However, despite the intensive investigations over a period of more than ten years and the numerous theoretical models proposed [6{9}] this simple law does not yet have a unique explanation. In the physics of conventional metals it is well established that Pt, for instance, has a linear resistivity but the underlying physics is completely dierent. A parallel between similar behaviour for Cu and the data for La_{1.825} Sr_{0.175} CuO₄ and YBa₂ Cu₃O₇ is available as well [1]. The linear temperature dependence of the resistivity is one of the most discussed problems in the physics of high-T_c superconductors [10].

The aim of this paper is to present a simple model estimation explaining the $_{\rm ab}$ / T behaviour. Our model is based on the strong anisotropy of the electrical resistivity in layered cuprates. In the c-direction, perpendicular to the conducting CuO $_2$ planes (ab-planes), the electrical resistivity $_{\rm c}$ is signicantly lower than the in-plane one $_{\rm ab}$. For the c-polarised electric elds also the plasm a frequency $!_{\rm c}$ can be lower than the critical temperature

$$h!_{c} < k_{B} T_{c}$$
: (1.1)

Plasm a oscillations exist only in the superconducting phase. Plasm ons in superconductors are observable only in the superconducting phase while in the normal phase they are overdam ped. Therefore the criterion for applicability of the model is the lack of coherent transport in c-direction and almost frequency independent electromagnetic response for h! < kg T (in Ref. [11], for instance, the author nds that coherence is not very important for the norm all resistivity; for the applicability of our model it would su ce that only the m ean free path in c-direction be not signi cantly larger than the lattice constant q in the sam e direction). In this case the electric eld between the CuO2 planes can be considered as a ilassical eld and Boltzm ann's distribution for the energy of the plane capacitors form ed by these planes is applicable. Such a picture is probably most appropriate for YB a_2 C u_3 O $_7$ and Bi₂Ca₂SrCu₂O₈ which contain double CuO₂ layers spaced by distance d₀ almost corresponding to the diam eter of the oxygen ions. Every plaquete within a double CuO2 plane is considered here as an independent plane capacitor with capacitance $C = \mathbf{u}_0 a_0^2 = d_0$; where 10 Jm /C²; "0 being the dielectric perm eability of vacuum and a0 the lattice param eter of the CuO₂ plane; the distance between the copper and oxygen ions is thus given by $\frac{1}{2}a_0$:

II.M ODEL

The capacitors de ned in Sec. I are the main ingredient of the proposed mechanism for creation of resistivity. A coording to the equipartition theorem their average energy can be written as $\frac{1}{2C}\,hQ^2\,\dot{i}=\frac{1}{2}\,k_B\,T$; which gives for the averaged square of the electric charge

$$hQ^2 i = {}^{"}_0 \frac{a_0^2}{d_0} k_B T :$$
 (2.1)

Consider now the scattering of one nearly free charge carrier (e.g. a hole moving in a CuO_2 plane) by a localized charge Q . For de niteness the hole is assumed to move in the

x-direction and pass by the charge Q at m in im um distance r to it. The trajectory of the hole is approxim ated by a straight line and its velocity is nearly constant and corresponds in our model estimation to the Ferm i velocity v_F . The time needed for the charge carrier to pass by the scatterer (the grast-time) we evaluate as $_{\rm Q}$ ' $2r=v_F$ [12]. The maximal Coulomb force acting perpendicular to the trajectory is $F_{\rm ?}=e{\rm Q}=4$ " $_{\rm 0}r^2$: Hence for the perpendicular momentum gained by the scattered hole one has $p_{\rm ?}$ ' $_{\rm Q}F_{\rm ?}$: The latter quantity is much smaller than the Fermi momentum $p_F=m\,v_F$; and for small scattering angles $_{\rm r}$ 1 one has

$$r' \frac{p_?}{p_F} = \frac{A}{r}; \qquad (2.2)$$

where A = Q=4 " $_0$ E $_F$; E $_F$ = $\frac{1}{2}$ m v_F^2 is the Ferm i energy, m = m $_e$ m $_0$ is the electron mass. We note that the Rutherford scattering is the same both in classical and quantum mechanics and the Coulomb logarithms in the theory of plasma exceed the accuracy of such model estimations. In principle the classical and quantum results might slightly dier upon taking into account prefactors containing Coulomb logarithms, however, the dierence would be much smaller than the uncertainty introduced by the lack of knowledge of material and/or model parameters. Let us stress that any mechanism for electrical resistivity must incorporate in an essential way some mechanism for transmission of the electron quasimomentum to the lattice. The capacitors model does this implicitly. The thermally excited charges in the capacitors play the role of the defects in the metal. Strictly speaking, the model considered is not purely electronic. It contains implicitly some weak inelastic electron-phonon interaction. In spite of its large relaxation time the latter ensures the equipartition theorem for the thermal energy of the independent capacitors.

The picture outlined above can be easily generalized to account for the in uence of all scattering plaquetes along the x=0 line. A coordingly, the charge carrier travels at distance $r=a_i$; $2a_i$; $3a_i$; $3a_i$:... Since the charges of the capacitors are independent random variables the average square of the scattering angle is an additive quantity [13]

$$h^{2}i_{line} = {\stackrel{X}{i}} h^{2}_{r}i = 2 \frac{A}{a_{0}}^{2} 1 + \frac{1}{2^{2}} + \frac{1}{3^{2}} + ::: :$$
 (2.3)

The eld outside the plane capacitors is essentially a dipole eld, however, we will not discuss such details because the corresponding correction gives a factor of order of one: (2) = $1 + 1 = 2^2 + 1 = 3^2 + \dots = 2^2 = 6'$ 1:

Now let us apply the discrete lattice model in order to address the discipline of the charge carrier momentum on the Fermi surface. The mean free path 1 is the distance after which the charge carrier "forgets" the direction of its earlier motion and scatters by 90 = 2 having travelled a distance equal to $1=a_0$ lattice constants, i.e.

$$h^{2}i_{l=a_{0}} = \frac{1}{a_{0}}! h^{2}i_{line} = \frac{1}{2}!$$
 (2.4)

Consequently, for the mean free path [14] we get nally

$$1=3 \frac{4 \cdot 0}{e^2} \frac{E_F^2 d_0}{k_B T} a_0: \qquad (2.5)$$

Inserting the transport life-time of the carriers de ned form et als as $_{\rm tr}$ = $l=v_F$ in D rude's form ula for the conductivity

$$= \frac{ne^2}{m} = \frac{1}{7}; (2.6)$$

where n is the number of charge carriers per unit volume and e is the electron charge, one recovers the linear temperature dependence of the resistivity (distinguishing feature for the classical statistics, cf. [15])

$$(T) = \frac{p_F}{ne^2 1} = \frac{p_F}{3 (4 \cdot n_0) nd_0 a_0 E_F^2} k_B T = \frac{k_B T}{3 \cdot 2 \cdot n_0 nd_0 a_0 m v_F^3};$$
 (2.7)

It is remarkable that the squared electron charge e^2 is cancelled and h does not appear explicitly as well. The electrical resistivity is by denition a property of the normal state whereas the cuprates have attracted attention because of their high T_c : That is why we consider it useful to perform a comparison with the experiment employing parameters of the superconducting phase. For clean superconductors when the mean free path $1(T_c)$ is much larger than the G inzburg-Landau coherent length $_{ab}(0)$ we can evaluate the electron ass m_e as half of the electron ass of the C cooper pairs. For thin cuprates m_e in m_e as of the C cooper pairs is determined by the electrostatic modulation of the kinetic inductance [16], but in principle it is also accessible from the Bernoulli elect [17], the D oppler electron density can be extracted from the extrapolated to zero temperature in-plane penetration depth

$$\frac{1}{\frac{2}{3h}(0)} = \frac{0 \, \text{ne}^2}{m}; \qquad 0 = 4 \qquad 10^7; \qquad 0 = 1 = 0 \, \text{c}^2; \qquad c = 299792458 \, \text{m s}^{\,1}: \qquad (2.8)$$

The Fermi momentum p_F can be determined on the basis of the model of a two-dimensional (2D) electron gas which for bilayered cuprates gives

$$n = \frac{2}{c_0} n^{(2D)}; \qquad n^{(2D)} = \frac{p_F^2}{2 h^2};$$
 (2.9)

So after som e elem entary algebra the Eq. (2.7) takes the form

$$\frac{p_{\overline{m}e}}{\frac{5}{ab}(0)} \frac{d}{dT} \qquad C \qquad \frac{8}{3^{1=2}} \frac{k_B e^5}{m_0^{1=2} (2 h)^3} \frac{\frac{5=2}{0}}{\frac{1}{a_0 d_0 c_0^{3=2}}} = const:$$
 (2.10)

We expect a weak doping dependence of the left-hand side of the above equation, while

$$T_c / E_F / n^{(2D)} / 1 = \frac{2}{ab}(0);$$
 for n_{opt} (2.11)

can vary signi cantly upon going from underdoped to optimally doped regime $n_{\rm opt}$. In the overdoped regime $n > n_{\rm opt}$ the resistivity often displays non-linear tem perature dependence. Simultaneously, if the doping dependence of the elective mass is negligible for n $n_{\rm opt}$; i.e. means, the model predicts

$$\frac{d}{dT} / \int_{ab}^{5} (0) / \frac{1}{n^{5-2}} / \frac{1}{T_{c}^{2.5}}; \text{ for } n_{opt}$$
: (2.12)

Let us note also that for a single-plane m aterial $(d_0 - g)$ only the 2D density $n^{(2D)} = nc_0$; i.e., the number of electrons per unit area, is relevant for the bulk 3D resistivity. The cancellation of the lattice constant c_0 can by easily understood inspecting the expression for the bulk conductivity of a system with equidistant conducting planes $= c_0^1 n^{(2D)}_{tr}(c_0) = m$: A coording to the plane capacitor m odel, cf. Eq. (2.1), the scattering rate is proportional to c_0^1 and, according to Eq. (2.5), the transport life-time c_{tr} / c_0 : As a result, for single-plane m aterials does not depend on the interplane distance c_0 ; assuming $n^{(2D)} = const$:

III.NUM ERICAL EXAMPLE

Let us provide now an estim ate for v_F and 1 based on the proposed model for the set of parameters d=dT=0.5 cm =K [5], $n^{(2D)}=\frac{1}{2}a_0^2=3.37$ 10^4 cm 2 ; $n=1=(a_0^2c_0)=5.72$ 10^{12} cm 3 ; 2 h=p_F = $3.54a_0$; $a_0=3.85$ A; $c_0=11.8$ A; $d_0=3.18$ A; $m=m_e$ m; $m_e=3$; cf. Ref. [16], and $m_0=9.11$ 10^{31} kg. Substituting these parameters into Eq. (2.7) and Eq. (2.5) we get an acceptable value for the Fermi velocity (cf. Table 3 of Ref. [10], where 31, 140, 200 and 220 km/s estimations are cited)

$$v_{F} = \frac{k_{B}}{3^{2}m} \frac{a_{0}c_{0}}{d_{0}"_{0}} \frac{dT}{d} = 1.76 \quad 10^{5} \text{ m s}^{1} = 176 \text{ km/s};$$
 (3.1)

and for the mean free path, respectively

$$1(T = 300 \text{ K}) = 5:67a_0 = 22 \text{ A};$$
 (3.2)
$$\frac{1}{a_0}$$
 101:

For $T_c=90\,$ K and $_{ab}(0)=12\,$ A we have $_{ab}(0)=1(T_c)=16\%$; $_{ab}(0)=122\,$ nm, $_{ab}(0)=_{ab}(0)=101$; $8=(3^{-1})$ 1:50; this numerical prefactor slightly changes if we apply more sophisticated approach for treatment of electric eld uctuations and the electron scattering by the random electric potential. Finally for the constant C , introduced by Eq. (2.10) and describing the – correlations, we get C = 320 K 1 (m) 4 : These numerical estimates lead us to conclude that the suggested model does not contradict the experimental data, cf. Ref. [1,10]. Furthermore, we consider that a detailed state-of-the-art derivation of the charge density uctuation of the plasma in layered cuprates could be an adequate quantitative model for the theory of their electrical resistivity. A long the same line, a systematic study of the – correlations would provide an electric tool to analyse the scattering mechanisms in layered perovskites.

The mechanism of the electrical resistivity is qualitatively fairly simple and is schematically presented in Fig. 1. The conducting CuO_2 planes constitute plates of plane capacitors and one has to take into account the Boltzmann (or Rayleigh-Jeans) statistics of the electrostatic energy of the capacitors. The last criterion for applicability of the model is the signicant low frequency rejection coefficient for an electromagnetic wave from a single

CuO $_2$ plane. It exists only for high two-dimensional conductivity $c_0 > "_0c_{light}$ [2], where $_{ab}$ (4= c_0) = 300 sheet resistance is evaluated for B $_2$ Ca $_2$ SrCu $_2$ O $_8$ just above T $_c$: While moving in the conducting CuO $_2$ planes the charge carriers are scattered by charge density uctuations in the same planes. In fact it is a self-consistent problem for collisionless plasma. The electrical resistivity appears upon taking into account the charge density uctuations. This scattering mechanism is analogous to the Rayleigh's blue-sky law [21,22] where the light is scattered by uctuations of the air density. Only the \electron" sky is rather red. In case of Rutherford scattering the faster charges of smaller wavelength are scattered less intensively while for light the elect is opposite.

IV.DISCUSSION AND CONCLUSIONS

The num erical example presented in Sec. III dem onstrates that scattering by charge density uctuations can explain the total resistivity of layered cuprates or at least constitutes a signicant part of it. The plane capacitor is an important structural detail of the scenario. Now we want to address two interesting issues. (i) Whether the existence of high- T_c structures having linear resistivity is possible without the plane capacitor detail and vice versa? (ii) Why other layered structures do not display linear resistivity? The answers have qualitative character:

(i) H igh T_c superconductivity can exist even in artical structures having a CuO $_2$ m onolayer and the resistivity is yet linear. In this case the plane capacitors are m issing; however, one has to take into account the electric eld uctuations close to the two dimensional (2D) CuO $_2$ layer. The 2D plasm ons are gapless and overdam ped above T_c : Therefore we have to calculate 2D charge density uctuations and the corresponding therm odynam ic uctuations of the electric eld. Due to the equipartition theorem the linear resistivity is recovered again, with only the prefactor being dierent.

(ii) There are various articial metal-insulator structures where the temperature dependence of the in-plane conductivity is special and non universal. When a metallic layer contains even a few monolayers we should take into account that the electric eld does not penetrate through the metal. Thus due to trivial electrostatic reasons the thermodynamic uctuations of the electric eld in the insulator layers would be an inelicient mechanism for charge scattering in thick metallic layers. Metallic monolayers have residual resistivity related to defects, signicant electron-phonon coupling etc. According to Mattissen's rule we could search for the charge density uctuation part of the scattering, but it is unlikely that this mechanism dominates. The theory of uctuations of the electromagnetic eld between metallic layers (this is the geometry of the Casimire ect) is a typical problem in statistical physics, however, the dicult task will be the experimental separation of the linear term provided many other mechanisms contribute to the resistivity.

To sum m arise, we came to the conclusion that an important hint for the applicability of the suggested model will be the existence of linear resistivity in other layered structures containing no CuO_2 planes but having almost 2D charge carriers and of course good quality. If our simple electrostatic explanation is correct any layered material having good 2D metallic layers should display the same behaviour regardless of its electronic structure. In this case it is ensured that linear resistivity is not related to some species of subtle properties of electron band structure of the CuO_2 plane or some sophisticated non-Ferm i-liquid-like

strongly correlated electron processes due to Cu3d electrons, but rather to such a universal cause as the omnipresent uctuations of the electrom agnetic eld and related to them charge density uctuations who could be blind for the blue sky.

The linear resistivity of the layered ruthenates [23] could be considered as such an exam ple and crucial experiment. In Sr₂RuO₄ the temperature dependence of the Hall coecient is sim ilar to the one measured in cuprates and the striking linear dependence of the conductivity persists over the whole tem perature range 1 (1000 K [23]. It is in pressive to observe any physical quantity exhibiting linear behaviour over three orders of magnitude change of the tem perature although it is a simple consequence of the conventional transport theory of m etallic solids. The authors of Ref. [23] note that they were unaware of any model that speci cally predicts or can convincingly account for essentially linear behaviour of resistivity over three decades of tem peratures although m ost theories of high-T_c superconductivity discuss linear resistivity. Nevertheless they suggest that linear resistivity is not an exclusive feature of the normal state of high- T_c cuprates, but rather of all layered oxides especially perovskites, possibly even independently of the magnitude of T_c [23]. Indeed, Sr₂RuO₄ ($T_{\rm c}$ < 1K) presents an unequivocal demonstration that its linear resistivity is not related to processes involved in the pairing mechanism. The linear resistivity is created by thermally activated electric elds while the pairing could originate in the conventional Heisenberg and Heitler-London type exchange attraction, cf. Ref. [24].

The emerging consensus that the model and mechanism of high- T_c superconductivity must simultaneously explain both the linear normal resistivity and the superconducting gap is likely to be an erroneous presumption. It is not a priori clear why the high- T_c superconductivity should repeat the history of phonon superconductors [25]. One could think of the scattering mechanism as one that \lives" between the CuO $_2$ planes while the pairing mechanism is localized within them. The nal solution of the problem, however, would be rather given by the development of technologies for articial layered structures necessary for the oxide electronics in the next millennium [26].

Concluding, we believe that there is nothing mysterious [10] in the linear dependence of the in-plane resistance in high- $T_{\rm c}$ layered cuprates it is just a consequence of the well-known physical laws dating back to the end of X IX and the beginning of X X century.

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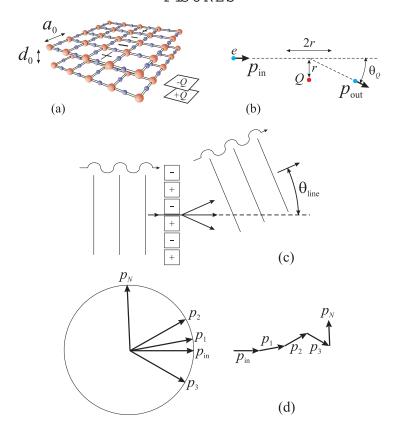


FIG.1. The plane capacitor scenario for the resistivity of layered cuprates in a nutshell: (a) Two conducting CuO $_2$ planes (spaced by distance d_0) of a layered perovskite are considered as an array of independent plain capacitors; $\frac{1}{2}a_0$ is the Cu-O ion distance. In every capacitor we have them ally uctuated charge Q for the avaraged square of which the equipartition theorem gives $k_0^2 = \frac{1}{2}k_B T$; where C is the capacitance; (b) In the model evaluation the charges are considered as point ones. A charge carrier (a hole with charge e) with momentum p_{in} passes near the scattering centre Q at distance r and deviates at a small angle $_{\mathbb{Q}}$ (r), with p_{out} being its momentum after the scattering event; (c) The electron waves are further scattered by a line of plane capacitors. The capacitor charges are independent random variables, thus the averaged square of the scattering angle $_{line}$ is an additive quantity. The Rutherford cross section is the same in classical and quantum mechanics; (d) Having crossed $N = l=a_0$ plaquete lines, the charge carrier "forgets" the direction of its initial momentum p_{in} . This is employed to evaluate the mean free path 1: The di usion of momentum on the Fermi surface is presented also as a trajectory containing segments in the real space p_{in} ; p_{in} ;